

ABSTRACT

PERSONNEL SECURITY INSPECTION METHOD AND PERSONNEL SECURITY INSPECTION SYSTEM

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The disclosure provides a personnel security inspection system and security inspection method. The personnel security inspection system includes a passive terahertz and/or micrometer wave inspection device and an active terahertz and/or micrometer wave inspection device provided at a security inspection site. The passive terahertz and/or micrometer wave inspection device is configured acquire terahertz and/or micrometer wave of a person in a crowd travelling through a security inspection passage and forms a real-time dynamic inspection image of the person. The active terahertz and/or micrometer wave inspection device is configured to acquire an active terahertz and/or micrometer wave inspection image of a static person in a re-inspection area.

Figure 1